

Application Data Sheet

Application Information

Application Type:: Regular
Subject Matter:: Utility
Title:: Focused Ion Beam Endpoint Detection
Using Charge Plus Detection Electronics
Attorney Docket Number:: TI-34625 (1962-04800)
Request for Early Publication?:: No
Request for Non-Publication?:: No
Suggested Drawing Figure:: 1
Total Drawing Sheets:: 5
Small Entity?:: No

Applicant Information

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Representative Information

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Assignee Information

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